AUTOMATIC LOCATION DETERMINATION OF DEVICE UNDER TEST

Abstract of Disclosure

A test device for a computer system includes a burn rack having a plurality of workcells. A simple network management protocol switch device is provided adjacent the burn rack. The switch device includes a plurality of ports. A plurality of cables are provided such that a respective cable interconnects a respective port of the switch device and a respective workcell. A monitor is provided adjacent the burn rack and is connected to a port of the switch device. At least one of the workcells has a computer mounted therein provided with a unique Mac Address and connected to the respective cable at the respective workcell. The monitor is connected to a burn rack database.

Fig. 1